

High-reliability discrete products and engineering services since 1977

BRX44-BRX49

SILICON CONTROLLED RECTIFIER

FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

Characteristics	Symbol	Value	Units
Peak repetitive forward and reverse blocking voltage ⁽¹⁾			
$(T_J = 25 \text{ to } 125^{\circ}\text{C}, R_{GK} = 1000\Omega)$			
BRX44		30	
BRX45	V _{DRM} , V _{RRM}	60	Volts
BRX46		100	
BRX47		200	
BRX49		400	
Forward current RMS (all conduction angles)	I _{T(RMS)}	0.8	Amps
Peak forward surge current			
(T _A = 25°C, ½ cycle, sine wave, 60Hz)	I _{TSM}	I _{TSM} 8	Amps
Circuit fusing considerations	l²t		A ² s
(T _A = 25°C, t = 8.3ms)	I t	0.15	AS
Forward peak gate power (T _A = 25°C)	P _{GM}	0.1	Watt
Forward peak gate current (T _A = 25°C)			
(300μs, 120 PPS)	I _{GM}	1	Amps
Peak reverse gate voltage	V _{GRM}	5	Volts
Operating junction temperature range @ rated V _{RRM} and V _{DRM}	T,	-40 to +125	°C
Storage temperature range	T _{stg}	-40 to +150	°C
Lead solder temperature (<1.5mm from case, 10 sec. max.)		+230	°C
Thermal Resistance, junction to case	R _{θJC}	75	°C/W
Thermal Resistance, junction to ambient	R _{θJA}	200	°C/W

Note 1: V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

ELECTRICAL CHARACTERISTICS ($T_C 25^{\circ}C$, $R_{GK} = 1000\Omega$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Units
Peak forward blocking current				
$(V_D = rated V_{DRM} @ T_C = 125^{\circ}C)$	I _{DRM}	-	100	μΑ
Peak reverse blocking current				
$(V_R = rated V_{RRM} @ T_C = 125^{\circ}C)$	I _{RRM}	-	100	μΑ
Forward "on" voltage ⁽²⁾	V			Volts
(I _{TM} = 1A peak @ T _A = 25°C)	V_{TM}	-	1.7	VOILS
Gate trigger current (continuous dc) ⁽³⁾				
(Anode voltage = 7V, $R_L = 100\Omega$, $T_C = 25$ °C)	I _{GT}	-	200	μΑ

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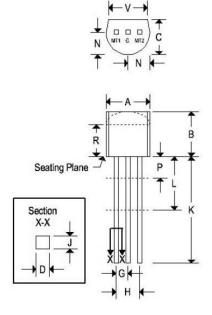
Characteristic	Symbol	Min	Max	Units
Gate trigger voltage (continuous dc)	V_{GT}			Volts
(Anode voltage = 7V, $R_L = 100\Omega$)				
(Anode voltage = rated V_{DRM} , $R_L = 100\Omega$)				
T _C = 25°C		-	0.8	
$T_C = -40$ °C		-	1.2	
T _C = 125°C		0.1	-	
Holding current	I _H			mA
(Anode voltage = 7V, initiating current = 20mA)				
T _C = 25°C		-	5	
$T_C = -40$ °C		-	10	

Note 2: Forward current applied for 1 ms maximum duration, duty cycle \leq 1%.

Note 3: R_{GK} current is not included in measurement.

MECHANICAL CHARACTERISTICS

Case	TO-92
Marking	Body painted, alpha-numeric
Pin out	See below



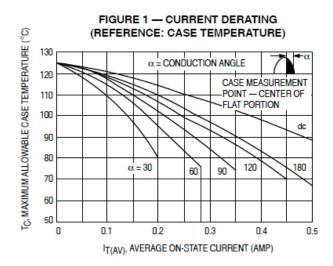
	TO-92			
	Inc	hes	Millimeters	
	Min	Max	Min	Max
Α	0.175	0.205	4.450	5.200
В	0.170	0.210	4.320	5.330
С	0.125	0.165	3.180	4.190
D	0.016	0.022	0.410	0.550
F	0.016	0.019	0.410	0.480
G	0.045	0.055	1,150	1.390
H	0.095	0.105	2.420	2.660
J	0.015	0.020	0.390	0.500
K	0.500	-	12.700	
L	0.250		6.350	
N	0.080	0.105	2.040	2.660
Р	25	0.100		2.540
R	0.115	-	2.930	7.
٧	0.135	44	3.430	



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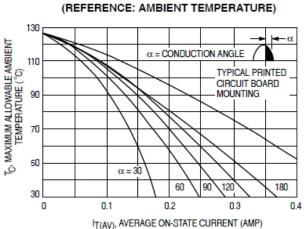


FIGURE 2 — CURRENT DERATING